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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Defeat Application Social No.	
Patent Application Senai No	10/015,28/
#Filing Date	July 7, 2003
Inventorship	Kunal R. Parekh et al.
Assignee	Micron Technology, Inc.
Group Art Unit	
	H. Jey Tsai
Attorney's Docket No	Ml22-2260
Title	Methods of Forming Memory Circuitry

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References - See Attached Form PTO-1449

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. Copies of the cited art are attached hereto. No admission is made regarding whether all the submitted references are prior art.

This Supplemental Information Disclosure Statement is being filed before the mailing of a first office action. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. § 1.17(p) to Deposit Account No. 23-0925.

Respectfully submitted,

Dated: 12 -16-03

Mark S. Matkin

Reg. No. 32,268

Form PTO 1448 E		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2260			SERIAL NO. 10/615,287				
PATENT AND TRADEMARK OFFICE DEC 1 6 2003 USE OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Kunal R. Parekh et al.							
DEC 1 6 2003 SUCUSe several sheets if r				FILING DATE July 7, 2003			GR 28	OUP 12	li li		
U.S. PATENT DOCUMENTS											
*Examiner's Initials		Document Number	Date	Name		Class	Subclass		Filing Date If Appropriate		
	AA	6,323,080 B1	11/27/01	Parekh		438	238				
	AB	6,284,641	09/04/01	Parekh		438	618				
	AC	6,214,727 B1	04/10/01	Parekh		438	666				
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FOREIGN PATENT DOCUMENTS											
		Document Number	Date	Date Country		Class		Trans	slation		
	AL							Yes	No		
	АМ			<u> </u>							
	AN							<u> </u>			
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)											
AO AO											
	AP				-						
EXAMINER		DATE CONS	SIDERED					•			
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.											